Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,383	DAVEY ET AL.	
Examiner	Art Unit	
Stacy B. Chen	1648	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
uspat, uspgpub, epo, jpo, derwent, medline, embase, biosis; see search history in file	10/28/2005	SF
PALM/EAST inventorship; updated	6/20/2006	SBC